


<b>Search Notes</b>  	<b>Application/Control No.</b>  10517536	<b>Applicant(s)/Patent Under Reexamination</b>  VAN BEEK ET AL.
	<b>Examiner</b>  Williams, Arun	<b>Art Unit</b>  2809

SEARCHED			
Class	Subclass	Date	Examiner
320	112,113,121,148,155,158,163	AW	2/22/2007
324	427	AW	2/27/2007

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor and assignee search (PALM)	2/21/2007	AW
East (att'd)	2/21/2007	AW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner